

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10567757	OHNO ET AL.
Examiner	Art Unit	
Jafar Parsa	1621	

SEARCHED

Class	Subclass	Date	Examiner
570	165, 177, 178	3/26/2008	jp

SEARCH NOTES

Search Notes	Date	Examiner
STN	3/20/2008	jp
inventor name search	3/26/2008	jp

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner